

## Description

The IRLR7833TRLPBF uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

# D S

#### TO-252-2L

## **General Features**

 $V_{DS} = 30V I_{D} = 100 A$ 

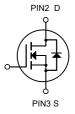
 $R_{DS(ON)} < 5m\Omega$  @  $V_{GS}=10V$ 

## **Application**

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

## **Package Marking and Ordering Information**

| Product ID     | Pack      | Brand      | Qty(PCS) |
|----------------|-----------|------------|----------|
| IRLR7833TRLPBF | TO-252-2L | HXY MOSFET | 2500     |

# Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

| Symbol                                | Parameter   |                                       | Rating     |      |
|---------------------------------------|---|---------------------------------------|------------|------|
| VDS                                   | Drain- Source Voltage   | 3                                     | 30         |      |
| VGS                                   | Gate-Source Voltage   | ±                                     | ±20        |      |
| I <sub>D</sub> @T <sub>C</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | 10                                    | 100        |      |
| I <sub>D</sub> @T <sub>C</sub> =100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | V <sub>GS</sub> @ 10V <sup>1</sup> 57 |            | А    |
| I <sub>D</sub> @T <sub>A</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | 27                                    | 17         | А    |
| I <sub>D</sub> @T <sub>A</sub> =70°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | 23                                    | 14.5       | А    |
| Ірм                                   | Pulsed Drain Current <sup>2</sup>                               | 16                                    | 160        |      |
| EAS                                   | Single Pulse Avalanche Energy <sup>3</sup>                      | 11:                                   | 115.2      |      |
| las                                   | Avalanche Current   | 4                                     | 48         |      |
| P <sub>D</sub> @T <sub>C</sub> =25°C  | Total Power Dissipation <sup>4</sup>                            | 5                                     | 53         |      |
| P <sub>D</sub> @T <sub>A</sub> =25°C  | Total Power Dissipation <sup>4</sup>                            | 6 2.4                                 |            | W    |
| Тѕтс                                  | Storage Temperature Range                                       | Storage Temperature Range -55         |            | °C   |
| TJ                                    | Operating Junction Temperature Range                            | -55 to                                | -55 to 175 |      |
| R <sub>θ</sub> JA                     | Thermal Resistance Junction-ambient (Steady State) <sup>1</sup> | 6                                     | 62         |      |
| Reja                                  | Thermal Resistance Junction-Ambient ¹ (t ≤10s)                  |                                       | 25         |      |
| R <sub>e</sub> Jc                     | Thermal Resistance Junction-Case <sup>1</sup> 2.8               |                                       | .8         | °C/W |



## Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

| Symbol                        | Parameter                                    | Conditions   | Min. | Тур.  | Max. | Unit  |
|-------------------------------|--|--|------|-------|------|-------|
| BVDSS                         | Drain-Source Breakdown<br>Voltage            | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                          | 30   |       |      | V     |
| ∆BVɒss/∆Tɹ                    | BV <sub>DSS</sub> Temperature<br>Coefficient | Reference to 25°C , I <sub>D</sub> =1mA                              |      | 0.028 |      | V/°C  |
|                               | Static Drain-Source On-                      | V <sub>GS</sub> =10V , I <sub>D</sub> =30A                           |      | 3.8   | 5.5  |       |
| RDS(ON)                       | Resistance <sup>2</sup>                      | V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A                          |      | 7.5   | 9    | mΩ    |
| V <sub>GS(th)</sub>           | Gate Threshold Voltage                       | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA             | 1.0  | 1.5   | 2.5  | V     |
| $\triangle V_{\text{GS(th)}}$ | V <sub>GS(th)</sub> Temperature Coefficient  | 133 130 , 13 200   |      | -6.16 |      | mV/°C |
|                               |  | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V ,<br>T <sub>J</sub> =25°C |      |       | 1    | uA    |
| IDSS                          | Drain-Source Leakage Current                 | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V ,<br>T <sub>J</sub> =55°C |      |       | 5    |       |
| Igss                          | Gate-Source Leakage Current                  | V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V                          |      |       | ±100 | nA    |
| gfs                           | Forward Transconductance                     | V <sub>DS</sub> =5V , I <sub>D</sub> =30A                            |      | 22    |      | S     |
| Rg                            | Gate Resistance                              | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V ,<br>f=1MHz                |      | 1.7   | 3.4  | Ω     |
| Qg                            | Total Gate Charge (4.5V)                     |  |      | 20    |      |       |
| Qgs                           | Gate-Source Charge                           | V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V ,                       |      | 7.6   |      | nC    |
| Qgd                           | Gate-Drain Charge                            |  |      | 7.2   |      |       |
| Td(on)                        | Turn-On Delay Time                           |  |      | 7.8   |      |       |
| Tr                            | Rise Time                                    | $V_{DD}$ =15V , $V_{GS}$ =10V , $R_{G}$ =3.3 $\Omega$                |      | 15    |      |       |
| $T_{d(off)}$                  | Turn-Off Delay Time                          | I <sub>D</sub> =15A  |      | 37.3  |      | ns    |
| T <sub>f</sub>                | Fall Time                                    |  |      | 10.6  |      |       |
| C <sub>iss</sub>              | Input Capacitance                            |  |      | 2295  |      |       |
| Coss                          | Output Capacitance                           | V <sub>DS</sub> =15V , V <sub>GS</sub> =0V ,<br>=1MHz                |      | 267   |      | pF    |
| Crss                          | Reverse Transfer Capacitance                 | I- IIVINZ  |      | 210   |      | -     |
| Is                            | Continuous Source Current <sup>1,5</sup>     | V <sub>G</sub> =V <sub>D</sub> =0V , Force                           |      |       | 80   | Α     |
| Іѕм                           | Pulsed Source Current <sup>2,5</sup>         | Current  |      |       | 160  | Α     |
| VsD                           | Diode Forward Voltage <sup>2</sup>           | GS=0 <b>V</b> , IS=1A ,<br>T <sub>J</sub> =25°C                      |      |       | 1    | V     |
| t <sub>rr</sub>               | Reverse Recovery Time                        | IF=30A , dI/dt=100A/μs ,   |      | 14    |      | nS    |
| Qrr                           | Reverse Recovery Charge                      | T <sub>J</sub> =25°C   |      | 5     |      | nC    |

#### Note:

<sup>1.</sup>The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

<sup>2.</sup>The data tested by pulsed , pulse width .The EAS data shows Max. rating .

<sup>3.</sup> The test cond  $\!\leq$  300us , duty cycle ition is V\_DD=25  $\!\leq$  V,V 2%GS =10V,L=0.1mH,I\_AS=53.8A

<sup>4.</sup>The power dissipation is limited by 175°C junction temperature

<sup>5.</sup>The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



## **Typical Characteristics**

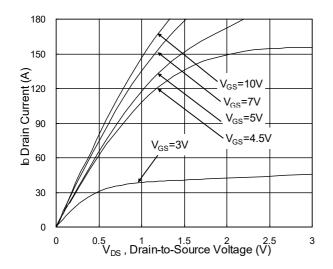


Fig.1 Typical Output Characteristics

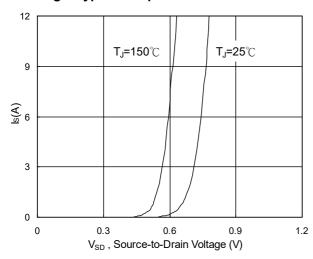


Fig.3 Forward Characteristics of Reverse

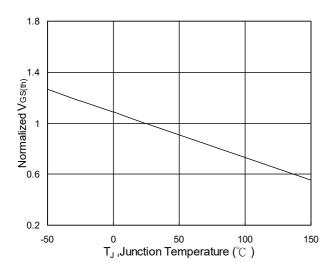


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

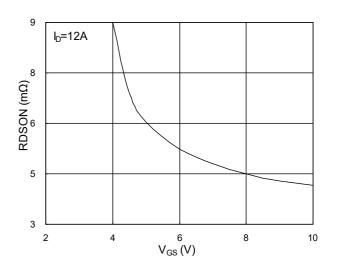


Fig.2 On-Resistance vs. G-S Voltage

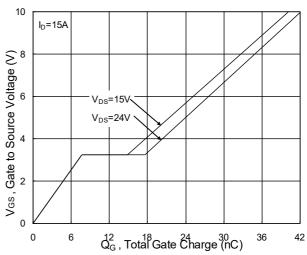


Fig.4 Gate-Charge Characteristics

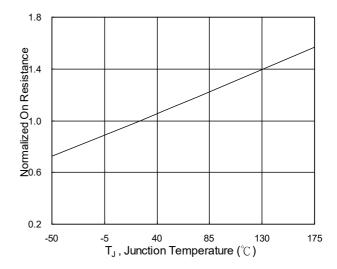
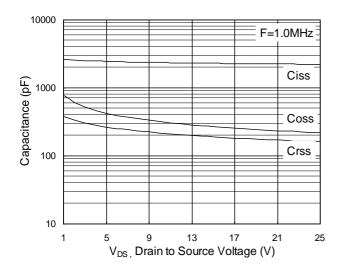


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



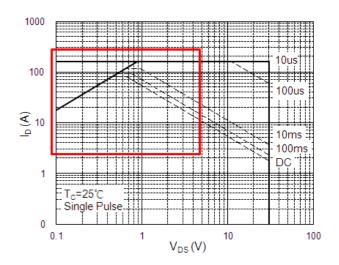


Fig.7 Capacitance

Fig.8 Safe Operating Area

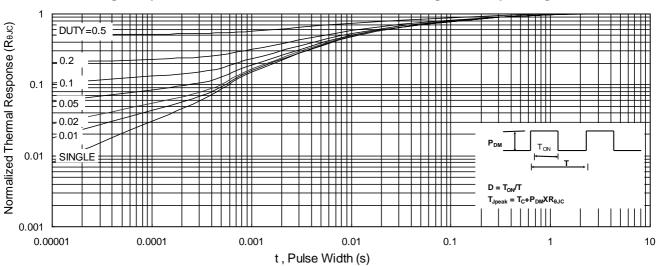


Fig.9 Normalized Maximum Transient Thermal Impedance

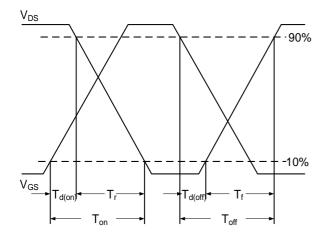


Fig.10 Switching Time Waveform

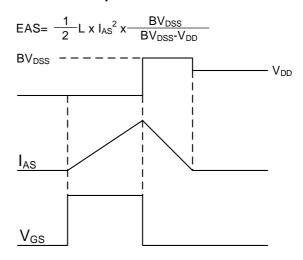
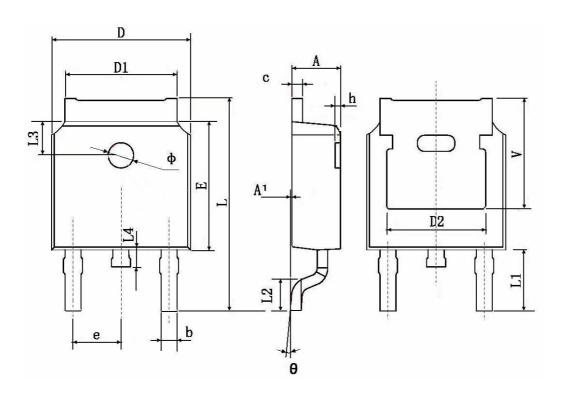


Fig.11 Unclamped Inductive Switching Waveform

# **TO-252-2L Package Information**



| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |       |  |
|--------|---------------------------|--------|----------------------|-------|--|
|        | Min.                      | Max.   | Min.                 | Max.  |  |
| Α      | 2.200                     | 2.400  | 0.087                | 0.094 |  |
| A1     | 0.000                     | 0.127  | 0.000                | 0.005 |  |
| b      | 0.660                     | 0.860  | 0.026                | 0.034 |  |
| С      | 0.460                     | 0.580  | 0.018                | 0.023 |  |
| D      | 6.500                     | 6.700  | 0.256                | 0.264 |  |
| D1     | 5.100                     | 5.460  | 0.201                | 0.215 |  |
| D2     | 0.483 TYP.                |        | 0.190 TYP.           |       |  |
| E      | 6.000                     | 6.200  | 0.236                | 0.244 |  |
| е      | 2.186                     | 2.386  | 0.086                | 0.094 |  |
| L      | 9.800                     | 10.400 | 0.386                | 0.409 |  |
| L1     | 2.900 TYP.                |        | 0.114 TYP.           |       |  |
| L2     | 1.400                     | 1.700  | 0.055                | 0.067 |  |
| L3     | 1.600 TYP.                |        | 0.063 TYP.           |       |  |
| L4     | 0.600                     | 1.000  | 0.024                | 0.039 |  |
| Ф      | 1.100                     | 1.300  | 0.043                | 0.051 |  |
| θ      | 0°                        | 8°     | 0°                   | 8°    |  |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |  |
| V      | 5.350 TYP.                |        | 0.211 TYP.           |       |  |



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